

SANYO Semiconductors DATA SHEET

5HN02C-

N-Channel Silicon MOSFET

General-Purpose Switching Device Applications

Features

- · Low ON-resistance.
- · Ultrahigh-speed switching.
- 4V drive.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V _{DSS}		50	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	ID		0.2	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	0.8	Α
Allowable Power Dissipation	PD		0.25	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0V	50			V
Zero-Gate Voltage Drain Current	IDSS	VDS=50V, VGS=0V			1	μΑ
Gate-to-Sourse Leakage Current	IGSS	V _{GS} =±16V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	VGS(off)	V _{DS} =10V, I _D =100μA	1		2.4	V
Forward Transfer Admittance	yfs	VDS=10V, ID=100mA	0.22	0.31		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	I _D =100mA, V _{GS} =10V		1.8	2.3	Ω
	R _{DS} (on)2	ID=50mA, VGS=4V		2.3	3.2	Ω
Input Capacitance	Ciss	V _{DS} =10V, f=1MHz		22		pF
Output Capacitance	Coss	V _{DS} =10V, f=1MHz		12		pF
Reverse Transfer Capacitance	Crss	V _{DS} =10V, f=1MHz		4.6		pF
Turn-ON Delay Time	td(on)	See specified Test Circuit.		12		ns
Rise Time	t _r	See specified Test Circuit.		12		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		260		ns
Fall Time	tf	See specified Test Circuit.		110		ns

Marking: YF Continued on next page.

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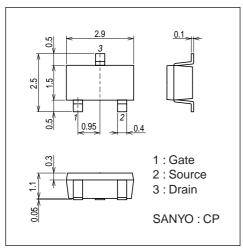
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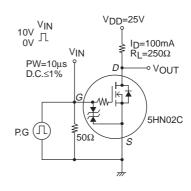
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Total Gate Charge	Qg	V _{DS} =10V, V _{GS} =10V, I _D =200mA		1.86		nC
Gate Source Charge	Qgs	V _{DS} =10V, V _{GS} =10V, I _D =200mA		0.28		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =10V, V _{GS} =10V, I _D =200mA		0.45		nC
Diode Forward Voltage	VSD	IS=200mA, VGS=0V		0.83	1.2	V

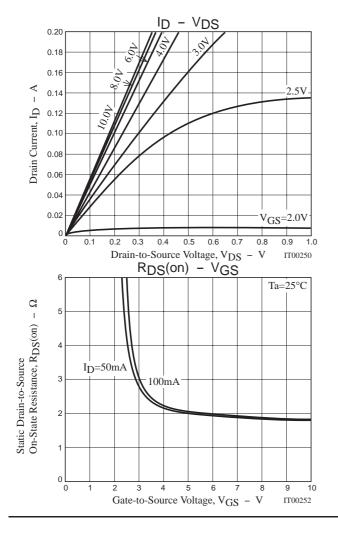
Package Dimensions

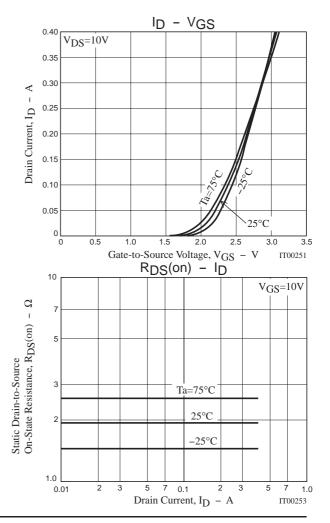
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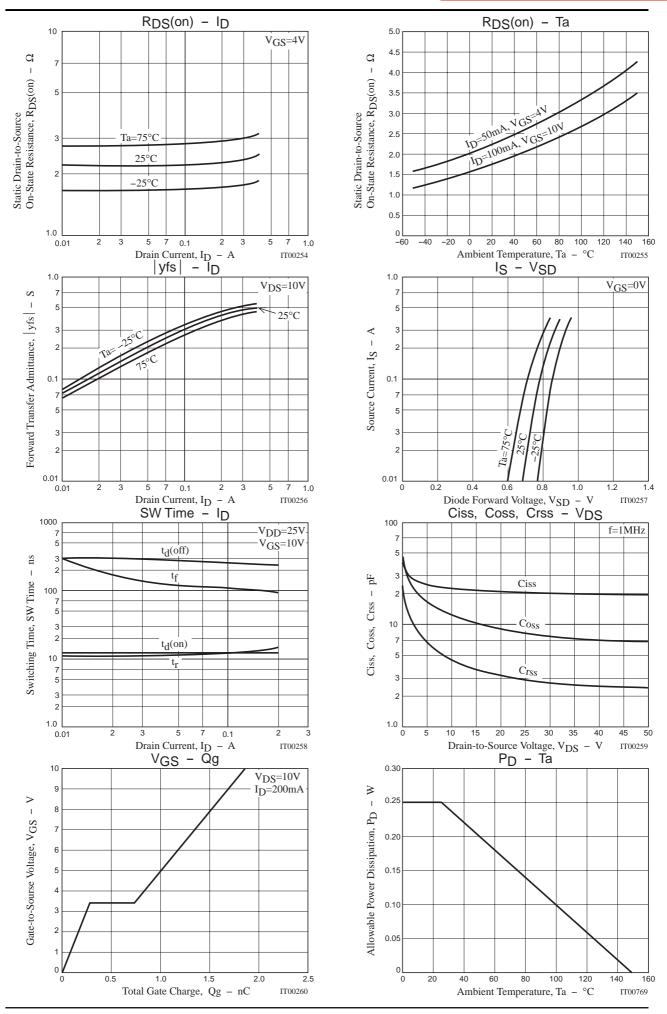


Switching Time Test Circuit









Note on usage: Since the 5HN02C is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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